

<b>Notice of References Cited</b>	Application/Control No. 09/743,594	Applicant(s)/Patent Under Reexamination SHIMONISHI, HIDEYUKI	
	Examiner Andrew Lee	Art Unit 2616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,259,699	07-2001	Opalka et al.	370/398
	B	US-			
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